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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet 1 of 1

Complete if Known				
Application Number	10/801,588			
Filing Date	March 17, 2004			
First Named Inventor	Soeparto Tandjoeng			
Art Unit	N/A			
Examiner Name	Not Yet Assigned			
Attorney Docket Number	M4065.0673/P673			

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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FOREIGN PATENT DOCUMENTS						
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NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²	
YW	CA	Data Sheet: "Synchronous DRAM," Micron Technology, Inc. © 2002, Micron Technology, Inc.		
YW	СВ	Digital Integrated Circuits, A Design Perspective Chapter 10, "Designing Memory and Array Structures," © 1996 Pretice Hall, Inc., pp. 551-583		
YW	CC	Testing Semiconductor Memories, Theory and Practice, A.J. van de Goor, Chapter 4, "Functional RAM chip testing", © 1991 John Wiley & Sons, pp. 93-105		

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/Yolanda Wilson/

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